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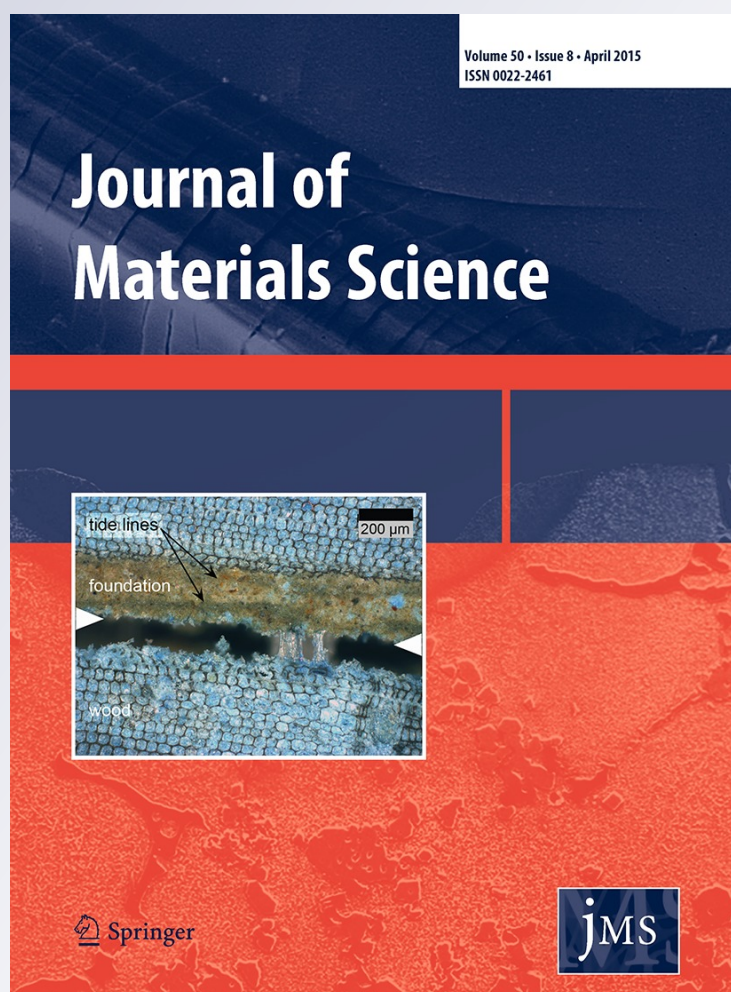
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Investigation of Er-doped Sc_2O_3 transparent ceramics by positron annihilation spectroscopy

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Abstract 0.25 at.% Er-doped Sc_2O_3 transparent ceramics fabricated using the two-step sintering method with different combinations of sintering temperatures were investigated by positron annihilation spectroscopy. Analysis of the broadening of the annihilation photopeak revealed the presence of the same type of defect in all samples. The lack of long lifetimes ($\tau \geq 2$ ns) suggested no positronium formation or the lack of trapping sites large enough to trap positronium for long enough time for the annihilation to be observed. Analysis of positron annihilation lifetime revealed the presence of a single lifetime that ranged from 208 to 219 ps, depending on the sintering conditions. These results also suggest the absence of a significant presence of vacancy clusters and other larger open-volume defects, and that the dominant open-volume defect corresponds to monovacancies and/or complex defects associated with monovacancies. The bulk lifetime of Er-doped scandia is estimated to be equal or lower than 208 ps.

Introduction

Cubic Sc_2O_3 is a promising optical material due to its wide optical transparency window related to a band gap of 5.7 eV that can readily accommodate rare earth dopants spanning emissions from the visible to infrared spectral regions. These properties combined with a high thermal conductivity of 17 W/mK make this material an attractive host for high power solid state lasers [1]. However, in practice, the growth of Sc_2O_3 single crystals is difficult, often resulting in small and contaminated specimens [2]. Accordingly, the growth of scandia crystals is an active research topic presently [3]. In order to circumvent crystal growth limitations, Li et al. proposed and fabricated 1-mm-thick transparent ceramics of scandia that reached about 57 % transmittance in the visible region, while estimating the maximum theoretical transmittance to be 79 % [2]. Later, these authors reported improved transmittance of about 70 % [4]. At the same time, Lu et al. reported on continuous wave (CW) laser oscillation from Yb-doped Sc_2O_3 transparent ceramics [5]. These reports initiated intense research on the fabrication and application of scandia transparent ceramics as laser gain media and scintillators [6–12].

High temperature sintering allows for the consolidation of powders into dense ceramics below their melting temperature, and recently a method was proposed to decouple densification and crystal growth during sintering [13]. This innovative method was applied to the fabrication of nano/sub-micron-grained transparent ceramics of $\text{Y}_2\text{O}_3\text{:Er}$ [10, 14, 15], $\text{Sc}_2\text{O}_3\text{:Er}$ [16], $(\text{Tb}_{0.8}\text{Y}_{0.2})\text{Al}_5\text{O}_{12}$ [17], and $\text{Lu}_2\text{O}_3\text{:Er}$ [18]. Besides the success in achieving high transparency and enhanced mechanical properties [10] using this method, a detailed investigation of the open-volume defects remaining in materials prepared using the

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two-step sintering method has not been carried out. The technique of positron annihilation spectroscopy (PAS) is particularly sensitive to the presence of pores with a wide range of sizes. The rate of positron annihilation in matter is a function of the electron density, with lower annihilation rates exhibited by open-volume defects because of the low electron density. PAS has been employed to the characterization of sintered materials, including ZnO [19], yttria-stabilized zirconia [20], porous silica [21], and alumina [22], and in this work it is employed to investigate the effects of different two-step sintering conditions on the porosity of $\text{Sc}_2\text{O}_3\text{:Er}$ ceramics for the first time to the best of the authors' knowledge.

Experimental procedure

The fabrication of $\text{Sc}_2\text{O}_3\text{:Er}$ transparent ceramics is only briefly described here as it has been reported in detail elsewhere [16]. Starting nanopowders were prepared by a coprecipitation method in which a scandium nitrate solution was obtained by dissolving Sc_2O_3 powder in excess amounts of nitric acid at approximately 80 °C. Erbium nitrate pentahydrate was added into the scandium nitrate solution to yield 0.25 at.% Er-doped scandium nitrate solution. In order to prepare a scandium sulfate solution, Er-doped scandium hydroxide precipitate was first prepared by drop-wise adding a 1.0-M ammonium hydroxide solution into an equivolume amount of 0.2 M Er-doped scandium nitrate solution. Er-doped scandium sulfate was prepared by dissolving the hydroxyl precipitates with a stoichiometric amount of sulfuric acid. The Er-doped Sc_2O_3 nanopowders were prepared by adding drop-wise 1.0 M hexamethylenetetramine (HMT) solution into the 0.1-M Er-doped scandium sulfate solution under stirring at 80 °C. After washing and drying, the precursors were calcined at 1100 °C for 4 h under flowing oxygen gas to yield Er-doped Sc_2O_3 nanopowders. The calcined nanopowders were uniaxially pressed into pellets at approximately 15 MPa without any binder, followed by cold isostatic pressing at 200 MPa. The two-step vacuum sintering consisted of heating to a higher temperature (T_1) at a heating rate of 10 °C/min and immediately cooling down to a lower temperature (T_2) at a cooling rate of 50 °C/min, with the samples being held at T_2 for 20 h. T_1 was set at either 1450 or 1500 °C, while T_2 was varied between 1350 and 1450 °C. In order to obtain transparent ceramics, sintered samples were hot isostatically pressed at 1300 °C under an argon pressure of 206 MPa for 3 h.

The positron annihilation lifetime (PAL) was measured in a typical fast–fast coincidence set-up using two Photonis XP2020/URQ photomultiplier tubes (PMTs) with barium fluoride scintillators [23]. The start and stop signals from

the PMTs went to Ortec 583 constant fraction differential discriminators which were set to select the 1.27 MeV gamma ray from the $^{22}\text{NaCl}$ source for the start signal and the 0.511 MeV annihilation gamma ray for the stop signal. The signals went to an Ortec time-to-amplitude converter and then to an Ortec Trump multi-channel analyzer (MCA) installed in a computer and operated with the software Maestro. The $^{22}\text{NaCl}$ source, manufactured by Isotope Products Lab., was deposited on 12.5 micron titanium film, and covered and sealed with a second identical titanium film. The source was placed on the one-piece sample and the sample-source was sandwiched between two 1.4-mm titanium foils in order to stop all the positrons from the source. Lifetime runs were made to obtain 1–8 million events total.

The lifetime data were analyzed with the program LT (version 9) [24]. The resolution function was assumed to be two Gaussian functions and the range of data analyzed extended from a counting level about one tenth of the peak to well into the region of the constant random background. The lifetime data were fit with one lifetime component together with a source correction determined using the Monte Carlo code MCNP [25]. The procedure to establish the source correction was to measure the lifetime from the source between the titanium foils alone. The MCNP results were used to determine what fraction of the positron spectrum annihilates in the different parts of the sample-source: the $^{22}\text{NaCl}$ source, the titanium film covering the source, the sample, and the titanium foil covering the sample and source. In the lifetime data analysis, the contribution from the source consisted of two components, a short component due to both the titanium foil and the $^{22}\text{NaCl}$ source, and the longer component due to the $^{22}\text{NaCl}$ source. With the sample-source arrangement used, the contribution to the lifetime spectrum from positrons stopped in the sample was calculated to be 33 %. The MCNP modeling approach for correcting for annihilations in the titanium foil and source was checked by comparing results for two samples of mono-crystalline Si in the conventional two-sample configuration with the case used here of a single sample and titanium foil sandwiching the source. The lifetime results for the Si in the two set-ups agreed within the 2 % statistical error.

The Doppler broadening experiment was done with the same sample-source arrangement, but with the ^{22}Na source replaced with a ^{68}Ge source, using a liquid nitrogen cooled high purity germanium detector (HPGe) which is a 5.08-cm coaxial crystal with an aluminum cover. The output signal was processed by an Ortec 571 amplifier and then sent to a second Trump MCA. In the Doppler broadening experiments, data were collected to obtain 4 million events in the 511 keV peak. The analysis of the Doppler broadening spectrum was done with the Sigma Plot software

using an analysis program that analyzes the Doppler broadened 511 keV annihilation gamma ray and determines the S and W parameters for the peak. The S parameter was defined as the ratio of the number of counts within about 1 keV of the 511 peak center to the total number of counts in the peak, while the W parameter corresponded to the ratio of the number of counts in the wings of the peak to the total number of counts in the peak. In the analysis, a step-like background is calculated from the spectrum and subtracted before analysis. No correction has been made for the contribution from positron annihilation in the titanium foils of the source or the titanium substrate.

Optical transmittance measurements was carried out using a Perkin Elmer UV/VIS/NIR Lambda 900 spectrometer at normal incidence. The samples thickness is about 1 mm.

Results and discussion

Positrons from the $^{22}\text{NaCl}$ source irradiate all the surface of the sample with an average energy of 182 keV thus probing a region roughly $L_+ = 43\text{-}\mu\text{m}$ thick, where L_+ is the mean penetration depth of the positrons given by $L_+ (\text{nm}) = 40E_0(\text{keV})^{1.6}/\rho (\text{g/cm}^3)$ with E_0 being the positron energy and $\rho = 3.86 \text{ g/cm}^3$ the material density [26]. Previously, the average grain size of the transparent ceramics was determined to be in the $0.4\text{--}0.8 \mu\text{m}$ range [16], thus data extracted from the PAS measurements are truly representative of the microstructure of the samples as they include the contribution of numerous grains and grain interfaces in addition to open-volume defects. Neglecting annihilation-in-flight that has a very low probability to occur [27], positron annihilation with electrons of the solid occurs after thermalization. Delocalized (during diffusion) and trapped (in an open-volume defect) positrons, as well as positroniums, the unstable self-bonded electron–positron pairs formed when a thermalized positron is captured by an electron, can be annihilated with an electron. Besides the probabilities of formation and trapping, positronium formation also requires sufficiently large open volumes to occur. From these different annihilation mechanisms, delocalized positron annihilation yields the so-called ‘bulk’ lifetime, while the lifetimes for trapped positron and positronium annihilation are longer and sensitive to the local electron density. As a consequence, the annihilation lifetime is related to the size of the open-volume defect, keeping in mind that because of charge *versus* electrical neutrality considerations for positrons and positroniums, respectively, these species do not usually trap in the same sites depending on the charge state of the open volume related defect.

PAL measurements were carried out and a typical experimental result (open circles) together with its fitting analysis is illustrated in Fig. 1a. The dashed line corresponds to the sample contribution, the dotted and dot-dashed lines correspond to the two components of the source correction as discussed in the previous section, and the continuous line correspond to the best fit to the results. The residual difference between the experimental data and the best fit is shown in Fig. 1b. The results show that the annihilation lifetime distribution is limited to relatively short lifetime values that are as long as about 3 ns. Lack of long lifetimes ($\tau \geq 2 \text{ ns}$) suggests no positronium formation or the lack of trapping sites large enough to trap positronium for long enough time for the annihilation to be observed. If the lack of positronium formation is assumed to be due to the absence of large enough open-volume defects, then a limit for the maximum defect radius present in these samples can be estimated to be about 3 \AA based on the work of Ito, et al. [28]. For the coordination number (CN) 6 of scandia, the ionic radii of O^{2-} and Sc^{3+} are 1.26 and 0.885 \AA [29], respectively, suggesting the maximum open-volume defects to be clusters of 2–3 vacancies.

Further analysis of the lifetime data revealed the presence of a single lifetime that ranges from 208 to 219 ps, depending on the sintering conditions, as shown in Fig. 2. This analysis achieved a high degree of confidence with a fit variance ranging from 0.926 to 1.16. Moreover, these results were checked against a two lifetime analysis where

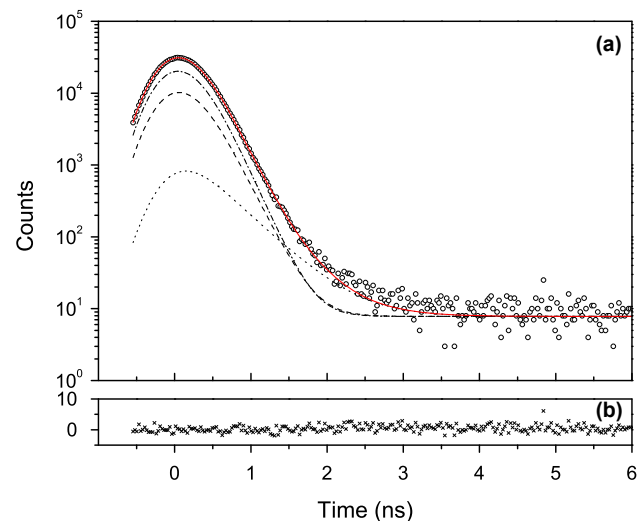


Fig. 1 PAL results illustrated for sample two-step sintered at $T_1 = 1500 \text{ }^\circ\text{C}$ and $T_2 = 1350 \text{ }^\circ\text{C}$ together with deconvolution analysis of the lifetime data. **a** Semi-log plot lifetime distribution up to 6 ns where the experimental results are shown as *open circles*, the best fit as *solid line*, the two source correction components as *dotted* and *dot-dashed lines*, and the sample lifetime as *dashed line*. **b** Linear plot showing the residual difference between the experimental and best fit results

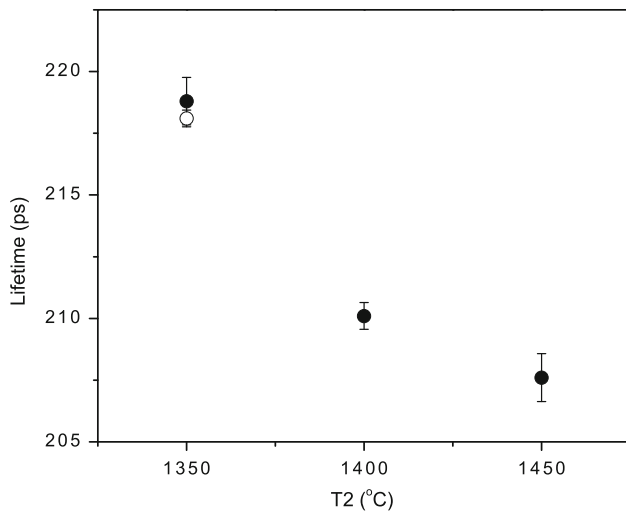


Fig. 2 Lifetime results of transparent scandia ceramics fabricated with two-step sintering with different conditions as a function of the T_2 temperature. Closed symbols correspond to $T_1 = 1500$ °C, and open symbol to $T_1 = 1450$ °C

the existence of two lifetimes was forced by fixing the value of the faster component assumed to be the bulk lifetime. In most cases, the contribution of the slower component was very low, below 1 %, and was considered unreliable, possibly being an artifact of the fitting procedure. Fits were also done allowing the source contribution to vary. These fits gave essentially the same result with slightly larger errors on the sample lifetime. While the fits obtained in this case were reasonable, it is generally better to fix source contribution to the calculated value since there is otherwise no way to constrain the variation in the fitting program and spurious results could occur when fitting two close values of lifetime. The analysis of the experimental lifetime data has to be considered under the possibility that several unresolved lifetimes exist. The decrease of the lifetime from 219 to 208 ps is interpreted as being due to the decrease of the contribution of positron annihilation in monovacancies and/or monovacancy-related defects due to the consolidation of the ceramic structure induced by higher temperature (T_2) sintering. This interpretation is in agreement with results reported from PAS characterization of a similar sesquioxide, Y_2O_3 [30]. Further support for the elimination of vacancies was obtained from optical transmittance measurements discussed later. The decrease of the lifetime together with the comparison between lifetime values, namely 218 and 219 ps, for samples prepared with $T_1 = 1450$ and 1500 °C, respectively, and $T_2 = 1350$ °C suggests the second sintering step at T_2 to control the final pore content. Also, the presence of Er^{3+} (ionic radius = 1.03 Å for CN = 6 [29]) substituting for Sc^{3+} will distort the lattice and may provide trapping sites for positrons. Based on these results and since no saturation for the

lifetime was reached (cf. Fig. 2), the bulk lifetime of Er-doped scandia is estimated to be equal or lower than 208 ps in agreement with the bulk lifetime of Y_2O_3 , 200 ps [30], and must be understood under the consideration that it may be possible to further lower it using different sintering conditions. These results also suggest the absence of a significant presence of vacancy clusters and other larger open-volume defects.

Additional insight into the defect type was obtained through the analysis of the broadening of the annihilation photopeak. Annihilation of positrons occurs mostly after thermalization and consequently the motion of the electron dominates the relative motion of the electron–positron pair. Since the gamma rays generated in the mutual electron–positron annihilation are Doppler shifted in energy according to the energy of the electron, the broadening of the annihilation photopeak can be related to the nature of the electron. Annihilation with the faster-moving core electrons contributes to the wings of the photopeak, while the slower valence electrons contribute to the central region of the photopeak. The photopeak can be arbitrarily divided in two regions, wings (W) and central (S), with the relative change of these two areas yielding information about the open-volume defects. The S versus W plot is presented in Fig. 3 together with a linear best fit to the data. The fact that a single straight line is capable of representing all the experimental data (within the error bars) suggests that the type of open-volume defect is the same in all samples [23, 31, 32]. Further, the S parameter and lifetime can be correlated in the case of systems with one type of vacancy trapping site such as the one under study here since a larger vacancy trapping site will lead to a larger positron lifetime. A larger trapping site will also lead to lower probability for

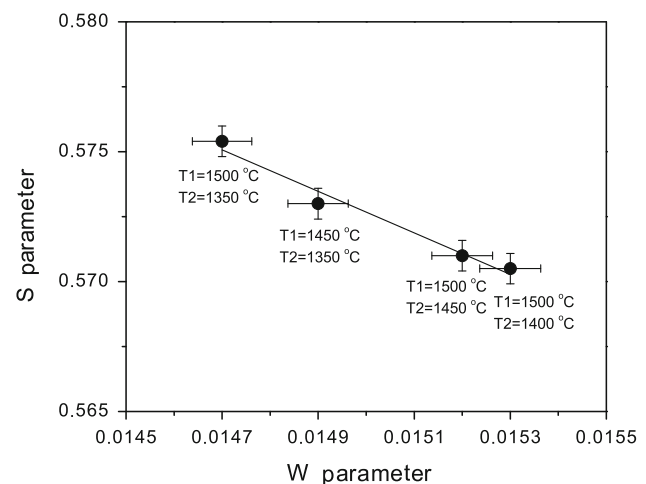


Fig. 3 S parameter versus W parameter, with each data point obtained from a sample prepared with different two-step sintering conditions. The line corresponds to a linear best fit to the data

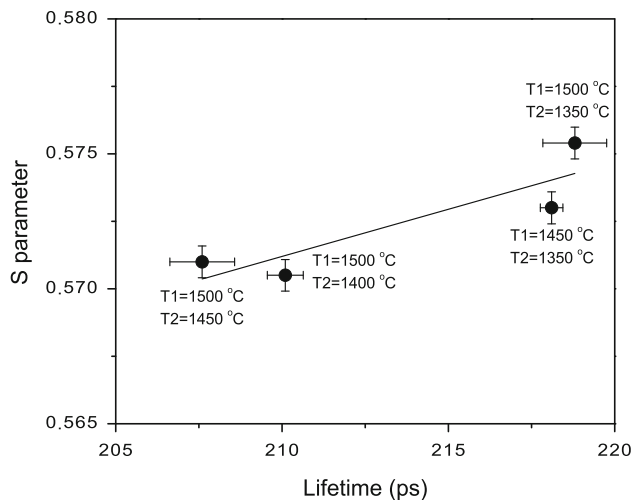


Fig. 4 S parameter versus lifetime, with each data point obtained from a sample prepared with different two-step sintering conditions. The line corresponds to a linear best fit to the data

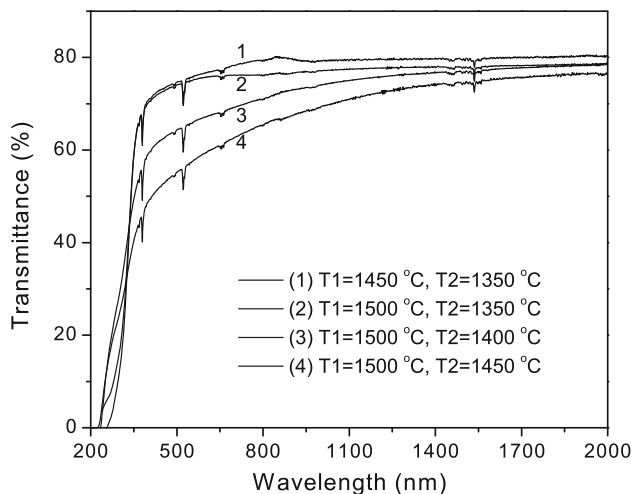


Fig. 5 Optical transmittance results for samples prepared with different two-step sintering conditions, as indicated

core annihilation and thus to a lower W and a larger S parameters. As can be seen in Fig. 4, the expected correlation in the S parameter and lifetime data is seen supporting the conclusion that as the lifetime and S parameter decrease, the size of the vacancy trapping site or number of such trapping sites decreases.

It is interesting to compare the PAS results with the optical transparency of the ceramics. The optical transmittance of the ceramics is presented in Fig. 5 for all synthesis conditions. The narrow absorption bands at about 380, 522, 654, and 1536 nm are originated in the Er^{3+} dopants [33]. Transmittance is higher for (1) $T_1 = 1450^\circ\text{C}$ and $T_2 = 1350^\circ\text{C}$, and (2) $T_1 = 1500^\circ\text{C}$ and $T_2 = 1350^\circ\text{C}$, with the difference between these spectra being of a few % only, and decreases for higher T_2

temperatures (with $T_1 = 1500^\circ\text{C}$ fixed). This trend corresponds to the behavior of the lifetime as a function of T_2 shown in Fig. 2 and confirms PAS as a useful tool in the characterization of pores in transparent ceramics.

Summary and conclusions

An investigation of 0.25 at.% Er-doped Sc_2O_3 ceramics fabricated using a two-step sintering method with different temperature combinations was carried out by means of PAS. The results suggest that the dominant open-volume defect, at least as detectable by PAS, corresponds to monovacancies and/or complex defects associated with monovacancies. These results confirm PAS to be a useful characterization technique for transparent ceramics. The bulk lifetime of Er-doped scandia is estimated to be equal or lower than 208 ps.

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